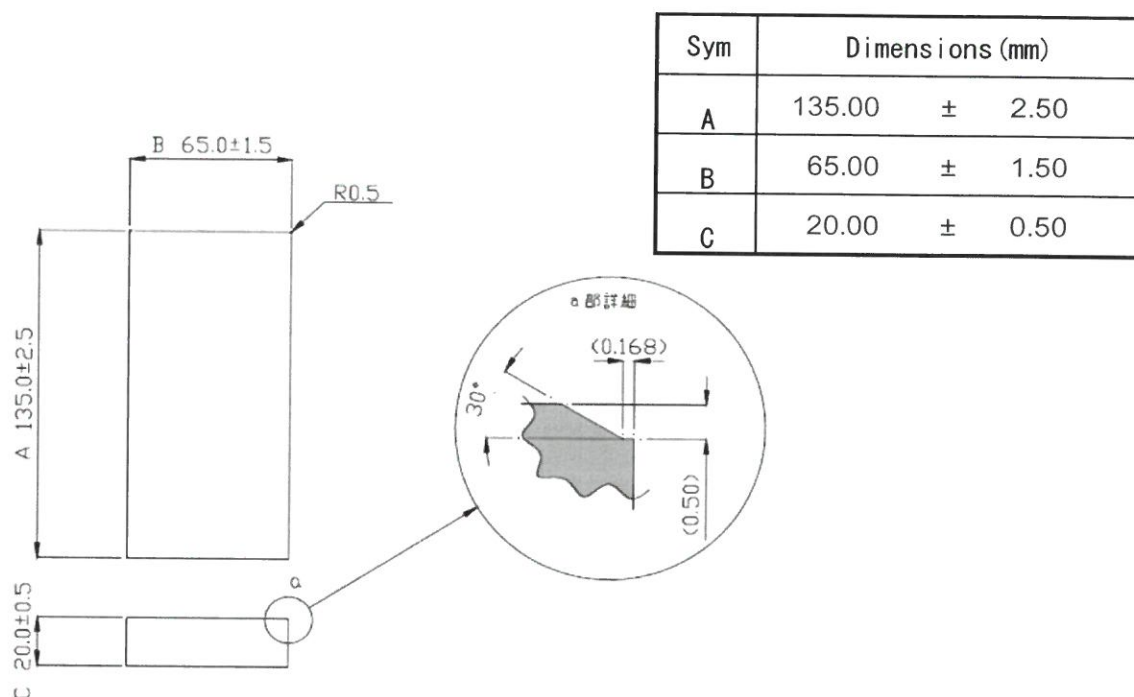


1. Dimensions (Unit : mm)



2. Electrical characteristics

Item	Specification	Test conditions
μi	2400 ± 25%	●EQUIP : LCR METER (Agilent 4284A) or equivalent ●MEASUREMENT METHOD : Single test ●FREQ. : 100 kHz ●LEVEL : 1.3 mA ●COIL : N=20 Ts ※ PC44 materail character

3. Marking

no marking

4. The core shall be supplied as pieces.

5. Manufacturing site

China:TDK Xiamen Co., Ltd

Specification No.

XL-0911-2700 (00)

TDK CORPORATION

Inspection Test Schedule

Magnetics Business Group of TDK CORPORATION
 performs outgoing inspection tests on the inspection items in Table-1.
 The inspection shall be performed according to ISO-2859-1
 Inspection level I (n=10, c=0 for dimension)

Table-1. AQL and Inspection items

	AQL	Inspection Items
A	0.4 %	Inductance and Crack
B	1.0 %	Dimensions
C	1.5 %	Chipping

Permissible limit of chips are prescribed as follows :

- (1) For one chips on a core piece,
 Depth of a permissible chip shall be 1.0 mm max.
 Permissible limit of the area of chips shall be 2.0 mm² max.
- (2) For the chips more than two on a core piece,
 Depth of a permissible chip shall be 1.0 mm max.
 Permissible limit of the total area of chips shall be 4.0 mm² max
- (3) Others.
 Not described above are based on IEC 60424 specification.

Specification No.

XL-0911-2700 (00)

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